



7N10Z

Power MOSFET

7A, 100V N-CHANNEL POWER MOSFET

DESCRIPTION

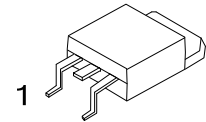
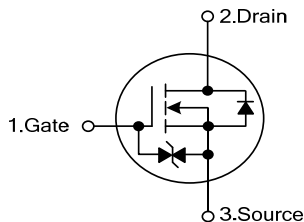
The UTC **7N10Z** is an N-Channel enhancement mode power MOSFET providing customers with excellent switching performance and minimum on-state resistance. The UTC **7N10Z** uses planar stripe and DMOS technology to provide perfect quality. This device can also withstand high energy pulse in the avalanche and the commutation mode.

The UTC **7N10Z** is generally applied in low voltage applications, such as DC motor controls, audio amplifiers and high efficiency switching DC/DC converters.

FEATURES

- * Low Gate Charge: 5.8nC (TYP.)
- * Low C_{RSS} : 10 pF (TYP.)
- * $R_{DS(ON)} = 0.35\Omega$ @ $V_{GS} = 10V$
- * Fast Switching
- * Improved dv/dt Capability

SYMBOL



TO-252

ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
7N10ZL-TN3-R	7N10ZG-TN3-R	TO-252	G	D	S	Tape Reel
7N10ZL-TN3-T	7N10ZG-TN3-T	TO-252	G	D	S	Tube

Note: Pin Assignment: G: Gate D: Drain S: Source

<p>7N10ZL-AA3-R</p> <p>(1)Packing Type</p> <p>(2)Package Type</p> <p>(3)Lead Free</p>	<p>(1) R: Tape Reel, T: Tube</p> <p>(2) TN3: TO-252</p> <p>(3) G: Halogen Free, L:Lead Free</p>
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■ ABSOLUTE MAXIMUM RATINGS ($T_C=25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Drain -Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 25	V
Continuous Drain Current $T_C=25^\circ\text{C}$	I_D	7	A
Pulsed Drain Current (Note 2)	I_{DM}	28	A
Single Pulsed Avalanche Energy (Note 3)	E_{AS}	50	mJ
Power Dissipation	P_D	2.5	W
Derate above 25°C		0.02	W/ $^\circ\text{C}$
Operating Junction Temperature	T_J	$-55 \sim +150$	$^\circ\text{C}$
Storage Temperature	T_{STG}	$-55 \sim +150$	$^\circ\text{C}$

Note: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating : Pulse width limited by maximum junction temperature

3. $L=26\text{mH}$, $I_{AS}=7\text{A}$, $V_{DD}=25\text{V}$, $R_G=25\Omega$ Starting $T_J=25^\circ\text{C}$

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ_{JA}	50	$^\circ\text{C/W}$

Note: When mounted on the minimum pad size recommended (PCB Mount)

■ ELECTRICAL CHARACTERISTICS ($T_C=25^\circ\text{C}$, unless otherwise specified)

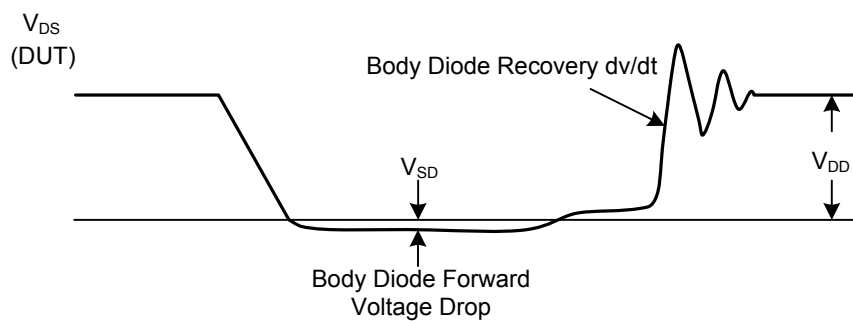
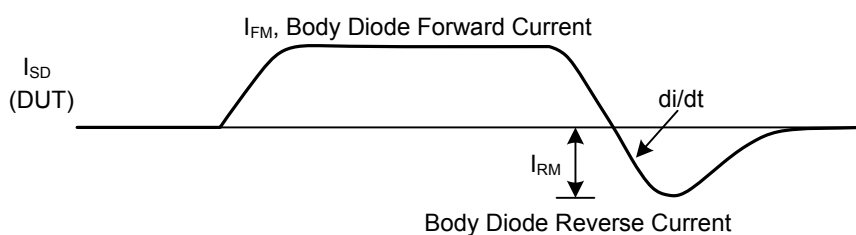
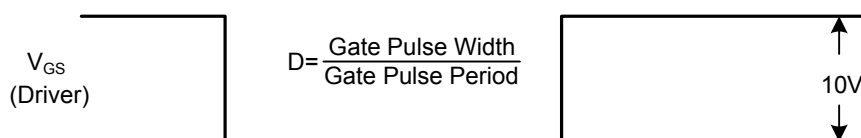
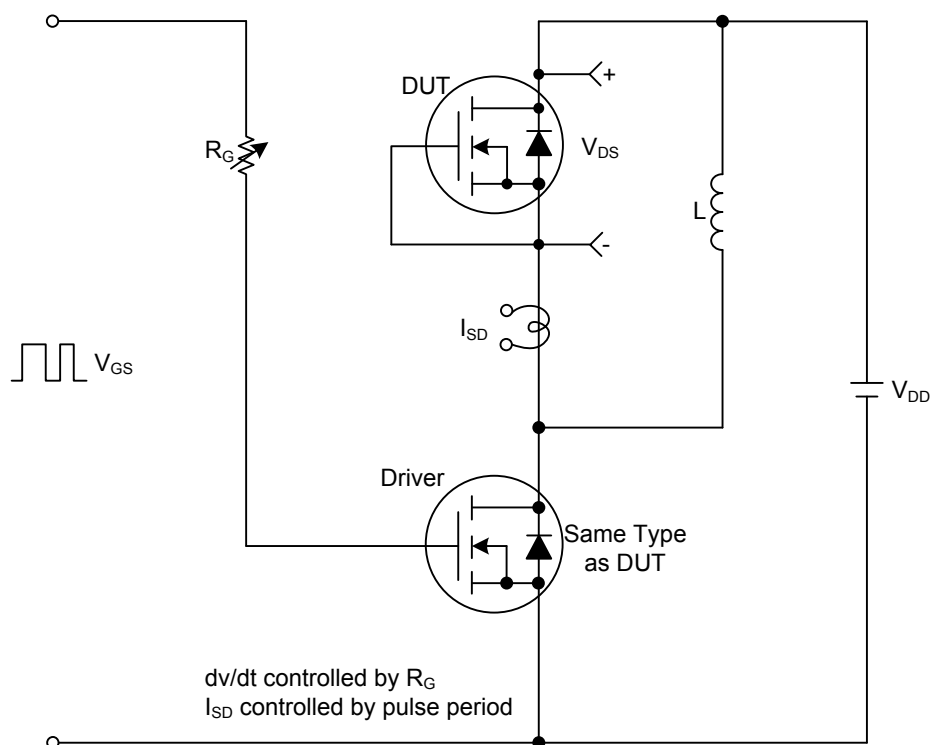
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250μA	100			V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =100V, V _{GS} =0V			1	μA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =±25V, V _{DS} =0V			±10	μA
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GS(TH)}	V _{DS} = V _{GS} , I _D =250μA	2.0		4.0	V
Static Drain-Source On-Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =3.5A		0.28	0.35	Ω
DYNAMIC PARAMETERS						
Input Capacitance	C _{ISS}	V _{DS} =25V, V _{GS} =0V, f=1.0MHz		190	250	pF
Output Capacitance	C _{OSS}			60	75	pF
Reverse Transfer Capacitance	C _{RSS}			10	13	pF
SWITCHING PARAMETERS						
Total Gate Charge	Q _G	V _{GS} =10V, V _{DS} =80V, I _D =7A (Note 1,2)		5.8	7.5	nC
Gate Source Charge	Q _{GS}			1.4		nC
Gate Drain Charge	Q _{GD}			2.5		nC
Turn-ON Delay Time	t _{D(ON)}	V _{DD} =50V, I _D =7A, R _G =25Ω (Note 1,2)		7	25	ns
Turn-ON Rise Time	t _R			24	60	ns
Turn-OFF Delay Time	t _{D(OFF)}			13	35	ns
Turn-OFF Fall-Time	t _F			19	50	ns
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS						
Maximum Continuous Drain-Source Diode Forward Current	I _S				7	A
Maximum Pulsed Drain-Source Diode Forward Current	I _{SM}				28	A
Drain-Source Diode Forward Voltage	V _{SD}	I _S =7A, V _{GS} =0V			1.5	V

Notes: 1. Pulse Test : Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$

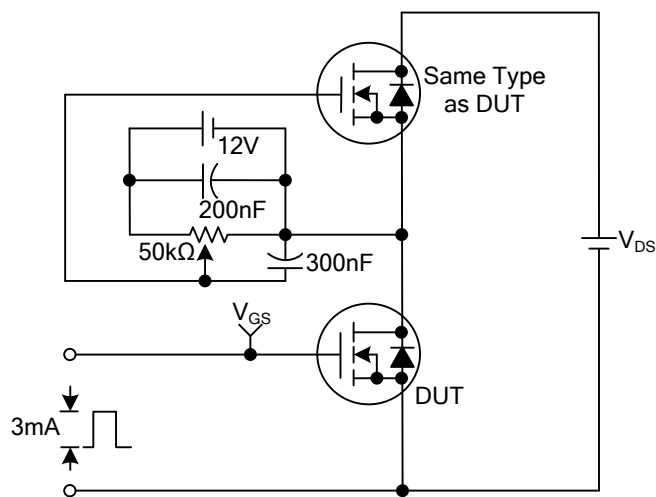
2. Essentially independent of operating temperature

■ TEST CIRCUITS AND WAVEFORMS

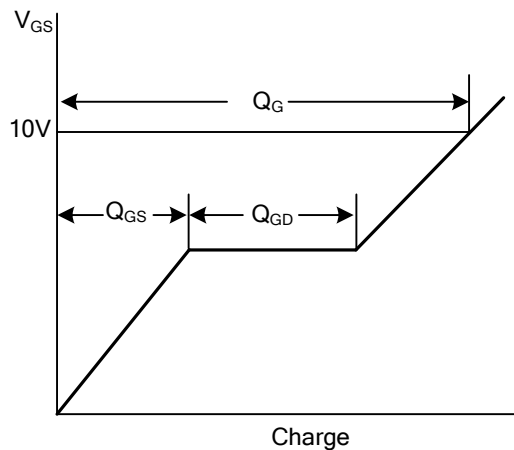
Peak Diode Recovery dv/dt Test Circuit & Waveforms



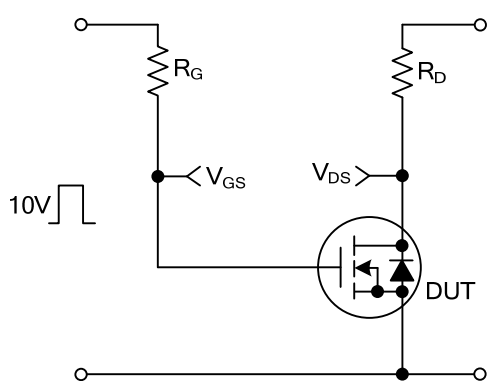
■ TEST CIRCUITS AND WAVEFORMS (Cont.)



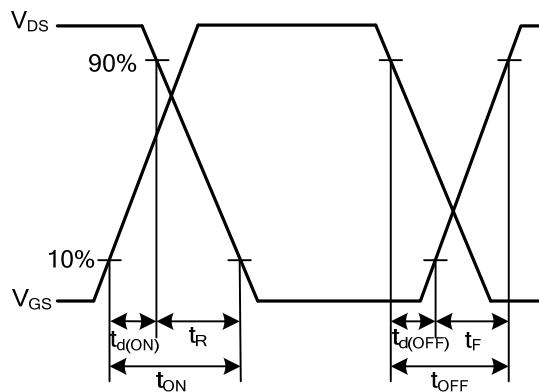
Gate Charge Test Circuit



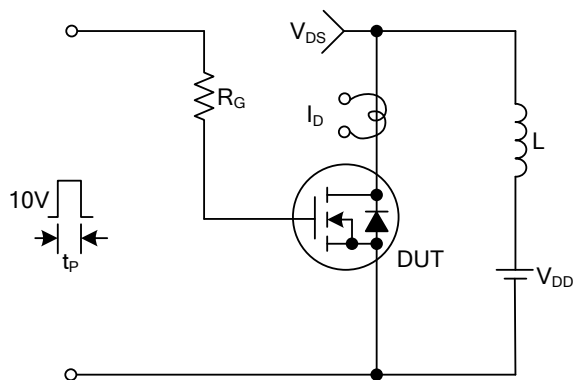
Gate Charge Waveforms



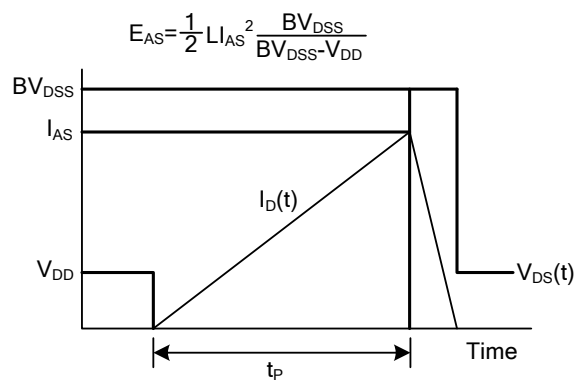
Resistive Switching Test Circuit



Resistive Switching Waveforms

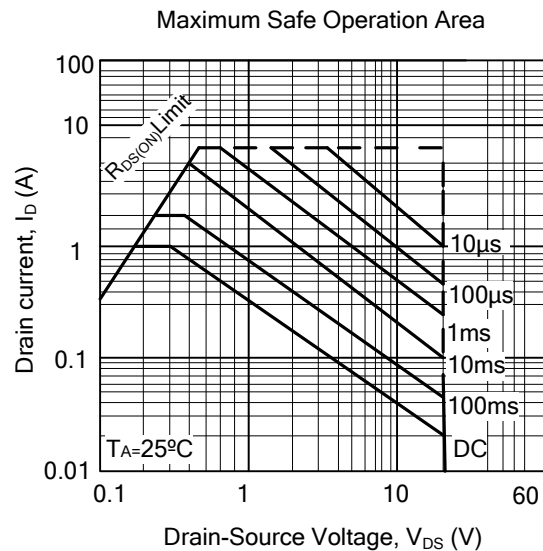
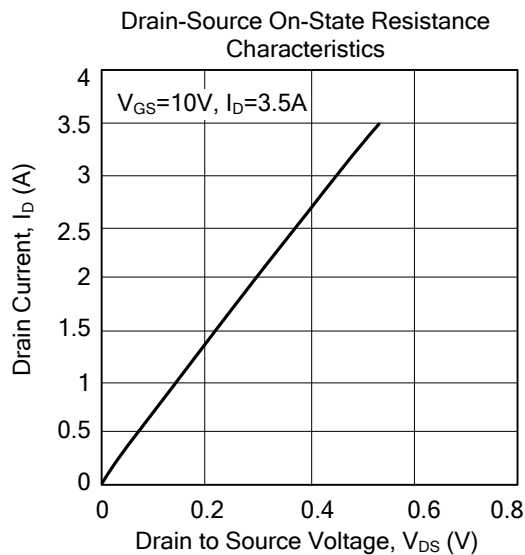
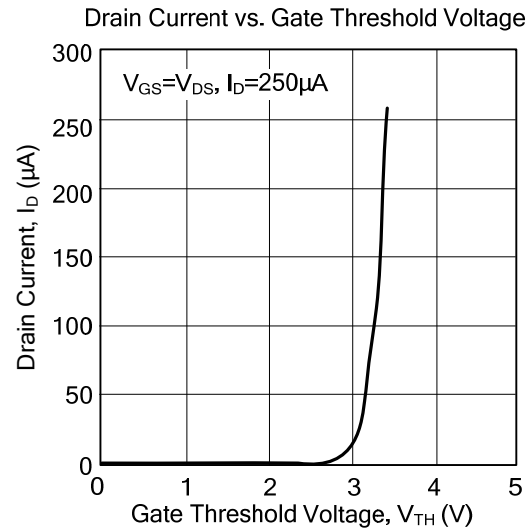
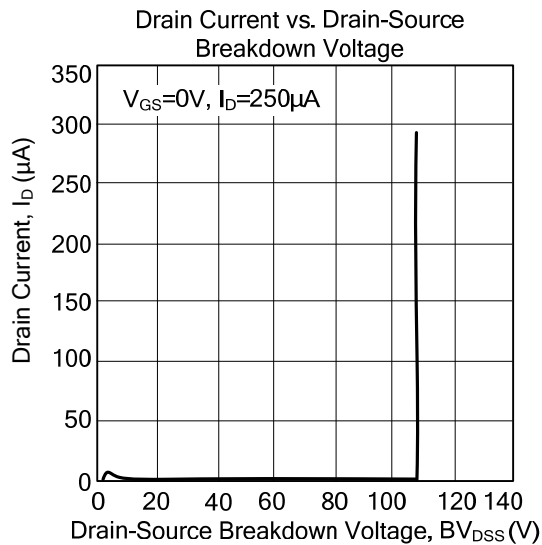


Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

■ TYPICAL CHARACTERISTICS



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